Wespack Phase Control Thyristor
Types N1817QL080 to N1817QL140
Development Type No.: NX371QL080-140

Absolute Maximum Ratings

	VOLTAGE RATINGS	MAXIMUM LIMITS	UNITS
V_{DRM}	Repetitive peak off-state voltage, (note 1)	800-1400	V
V_{DSM}	Non-repetitive peak off-state voltage, (note 1)	800-1400	V
V_{RRM}	Repetitive peak reverse voltage, (note 1)	800-1400	V
V_{RSM}	Non-repetitive peak reverse voltage, (note 1)	900-1500	V

	OTHER RATINGS		MAXIMUM LIMITS	UNITS
$I_{T(AV)M}$	Maximum average on-state current, T_{sink}=55°C, (note 2)		1760	A
$I_{T(AV)M}$	Maximum average on-state current. T_{sink}=85°C, (note 2)		1180	A
$I_{T(AV)M}$	Maximum average on-state current. T_{sink}=85°C, (note 3)		690	A
$I_{T(RMS)M}$	Nominal RMS on-state current, T_{sink}=25°C, (note 2)		3525	A
$I_{T(d.c.)}$	D.C. on-state current, T_{sink}=25°C, (note 4)		2945	A
I_{TSM}	Peak non-repetitive surge t_p=10ms, V_{rm}=60%V_{RRM}, (note 5)		22.0	kA
I_{TSM2}	Peak non-repetitive surge t_p=10ms, V_{rm}≤10V, (note 5)		24.2	kA
I^2t	I^2t capacity for fusing t_p=10ms, V_{rm}=60%V_{RRM}, (note 5)		$2.42×10^6$	A^2s
I^2t	I^2t capacity for fusing t_p=10ms, V_{rm}≤10V, (note 5)		$2.93×10^6$	A^2s
$(di/dt)_{cr}$	Critical rate of rise of on-state current (note 6)	(continuous, 50Hz)	100	A/µs
		(repetitive, 50Hz, 60s)	200	
		(non-repetitive)	400	
V_{RGM}	Peak reverse gate voltage		5	V
$P_{G(AV)}$	Mean forward gate power		4	W
P_{GM}	Peak forward gate power		30	W
$T_{j op}$	Operating temperature range		-40 to +125	°C
T_{stg}	Storage temperature range		-40 to +150	°C

Notes:-
1) De-rating factor of 0.13% per °C is applicable for T_j below 25°C.
2) Double side cooled, single phase; 50Hz, 180° half-sinewave.
3) Single side cooled, single phase; 50Hz, 180° half-sinewave.
4) Double side cooled.
5) Half-sinewave, 125°C T_j initial.
6) V_D=67% V_{DRM}, I_{TM}=2000A, I_{FG}=2A, t_r≤0.5µs, T_{case}=125°C.

Characteristics

	PARAMETER	MIN.	TYP.	MAX.	TEST CONDITIONS (Note 1)	UNITS
V_{TM}	Maximum peak on-state voltage	-	-	1.50	I_{TM}=3000A	V
V_{TM}	Maximum peak on-state voltage	-	-	1.90	I_{TM}=5300A	V
V_{T0}	Threshold voltage	-	-	0.955		V
r_T	Slope resistance	-	-	0.177		mΩ
$(dv/dt)_{cr}$	Critical rate of rise of off-state voltage	1000	-	-	V_D=80% V_{DRM}, linear ramp, gate o/c	V/µs
I_{DRM}	Peak off-state current	-	-	100	Rated V_{DRM}	mA
I_{RRM}	Peak reverse current	-	-	100	Rated V_{RRM}	mA
V_{GT}	Gate trigger voltage	-	-	3.0	T_j=25°C V_D=10V, I_T=3A	V
I_{GT}	Gate trigger current	-	-	300		mA
V_{GD}	Gate non-trigger voltage	-	-	0.25	Rated V_{DRM}	V
I_H	Holding current	-	-	1000	T_j=25°C	mA
t_{gd}	Gate-controlled turn-on delay time	-	0.6	1.5	V_D=67% V_{DRM}, I_T=2000A, di/dt=10A/µs, I_{FG}=2A, t_r=0.5µs, T_j=25°C	µs
t_{gt}	Turn-on time	-	1.2	2.5		µs
Q_{rr}	Recovered charge	-	1700	2150		µC
Q_{ra}	Recovered charge, 50% Chord	-	1150	-	I_{TM}=1000A, t_p=1000µs, di/dt=10A/µs, V_r=50V	µC
I_{rr}	Reverse recovery current	-	110	-		A
t_{rr}	Reverse recovery time	-	20	-		µs
t_q	Turn-off time	-	200	-	I_{TM}=1000A, t_p=1000µs, di/dt=10A/µs, V_r=50V, V_{dr}=80%V_{DRM}, dV_{dr}/dt=20V/µs	µs
		-	300	-	I_{TM}=1000A, t_p=1000µs, di/dt=10A/µs, V_r=50V, V_{dr}=80%V_{DRM}, dV_{dr}/dt=200V/µs	
R_{thJK}	Thermal resistance, junction to heatsink	-	-	0.023	Double side cooled	K/W
		-	-	0.046	Single side cooled	K/W
F	Mounting force	16	-	20	Note 2.	kN
W_t	Weight	-	330	-		g

Notes:-
1) Unless otherwise indicated T_j=125°C.
2) For other clamp forces, please consult factory.

Notes on Ratings and Characteristics

1.0 Voltage Grade Table

Voltage Grade	V_{DRM} V_{DSM} V_{RRM} V	V_{RSM} V	V_D V_R DC V
08	800	900	560
10	1000	1100	700
12	1200	1300	810
14	1400	1500	930

2.0 Extension of Voltage Grades

This report is applicable to other voltage grades when supply has been agreed by Sales/Production.

3.0 De-rating Factor

A blocking voltage de-rating factor of 0.13%/°C is applicable to this device for T_j below 25°C.

4.0 Repetitive dv/dt

Standard dv/dt is 1000V/µs.

5.0 Snubber Components
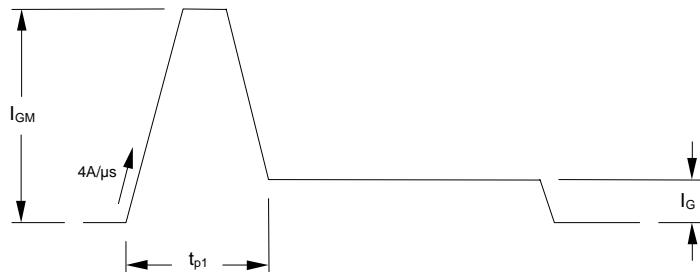
When selecting snubber components, care must be taken not to use excessively large values of snubber capacitor or excessively small values of snubber resistor. Such excessive component values may lead to device damage due to the large resultant values of snubber discharge current. If required, please consult the factory for assistance.

6.0 Rate of rise of on-state current

The maximum un-primed rate of rise of on-state current must not exceed 400A/µs at any time during turn-on on a non-repetitive basis. For repetitive performance, the on-state rate of rise of current must not exceed 200A/µs at any time during turn-on. Note that these values of rate of rise of current apply to the total device current including that from any local snubber network.

7.0 Gate Drive

The nominal requirement for a typical gate drive is illustrated below. An open circuit voltage of at least 30V is assumed. This gate drive must be applied when using the full di/dt capability of the device.

The magnitude of I_{GM} should be between five and ten times I_{GT}, which is shown on page 2. Its duration (t_{p1}) should be 20µs or sufficient to allow the anode current to reach ten times I_L, whichever is greater. Otherwise, an increase in pulse current could be needed to supply the necessary charge to trigger. The 'back-porch' current I_G should remain flowing for the same duration as the anode current and have a magnitude in the order of 1.5 times I_{GT}.

8.0 Computer Modelling Parameters

8.1 Device Dissipation Calculations

$$I_{AV} = \frac{-V_{T0} + \sqrt{V_{T0}{}^2 + 4 \cdot ff^2 \cdot r_T \cdot W_{AV}}}{2 \cdot ff^2 \cdot r_T}$$

and:

$$W_{AV} = \frac{\Delta T}{R_{th}}$$

$$\Delta T = T_{j\,max} - T_K$$

Where V_{T0}=0.955V, r_T=0.177mΩ,

R_{th} = Supplementary thermal impedance, see table below and

ff = Form factor, see table below.

Supplementary Thermal Impedance							
Conduction Angle	30°	60°	90°	120°	180°	270°	d.c.
Square wave Double Side Cooled	0.0322	0.0299	0.0284	0.0272	0.0255	0.0239	0.0230
Square wave Single Side Cooled	0.0548	0.0530	0.0516	0.0505	0.0488	0.0473	0.0460
Sine wave Double Side Cooled	0.0302	0.0278	0.0264	0.0254	0.0231		
Sine wave Single Side Cooled	0.0532	0.0511	0.0498	0.0488	0.0462		

Form Factors							
Conduction Angle	30°	60°	90°	120°	180°	270°	d.c.
Square wave	3.46	2.45	2	1.73	1.41	1.15	1
Sine wave	3.98	2.78	2.22	1.88	1.57		

8.2 Calculating V_T using ABCD Coefficients

The on-state characteristic I_T vs. V_T, on page 7 is represented in two ways;
(i)   the well established V_{T0} and r_T tangent used for rating purposes and
(ii)   a set of constants A, B, C, D, forming the coefficients of the representative equation for V_T in terms of I_T given below:

$$V_T = A + B \cdot \ln(I_T) + C \cdot I_T + D \cdot \sqrt{I_T}$$

The constants, derived by curve fitting software, are given below for both hot and cold characteristics. The resulting values for V_T agree with the true device characteristic over a current range, which is limited to that plotted.

25°C Coefficients		125°C Coefficients	
A	0.6593689	A	0.4183106
B	0.04406249	B	0.06693063
C	1.001743×10^{-4}	C	1.425135×10^{-4}
D	2.747447×10^{-3}	D	2.159445×10^{-3}

8.3 D.C. Thermal Impedance Calculation

$$r_t = \sum_{p=1}^{p=n} r_p \cdot \left(1 - e^{\frac{-t}{\tau_p}} \right)$$

Where $p = 1$ to n, n is the number of terms in the series and:

t = Duration of heating pulse in seconds.

r_t = Thermal resistance at time t.

r_p = Amplitude of p_{th} term.

τ_p = Time Constant of r_{th} term.

The coefficients for this device are shown in the tables below:

D.C. Double Side Cooled			
Term	1	2	3	4
r_p	0.01172636	4.471553×10^3	4.759634×10^3	2.027412×10^3
τ_p	0.7288979	0.1691487	0.0540350	3.174914×10^3

D.C. Single Side Cooled				
Term	1	2	3	4	5
r_p	0.03074297	2.648739×10^3	6.516549×10^3	4.230842×10^3	2.161992×10^3
τ_p	4.000628	1.346204	0.1822753	0.05086185	3.674937×10^3

9.0 Reverse recovery ratings

(i) Q_{ra} is based on 50% I_{rm} chord as shown in Diagram 1
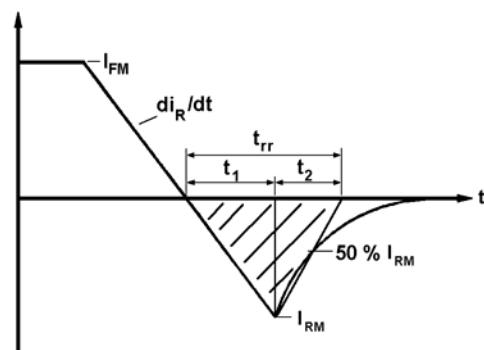
Diagram 1

(ii) Q_{rr} is based on a 150μs integration time i.e.

$$Q_{rr} = \int_{0}^{150\mu s} i_{rr}.dt$$

(iii)

$$K\ Factor = \frac{t_1}{t_2}$$

Curves

Figure 1 – On-state characteristics of Limit device

N1817QL080-140
Issue 1

$T_j = 25°C$ $T_j = 125°C$

Instantaneous On-state current - I_{TM} (A)

Instantaneous On-state voltage - V_{TM} (V)
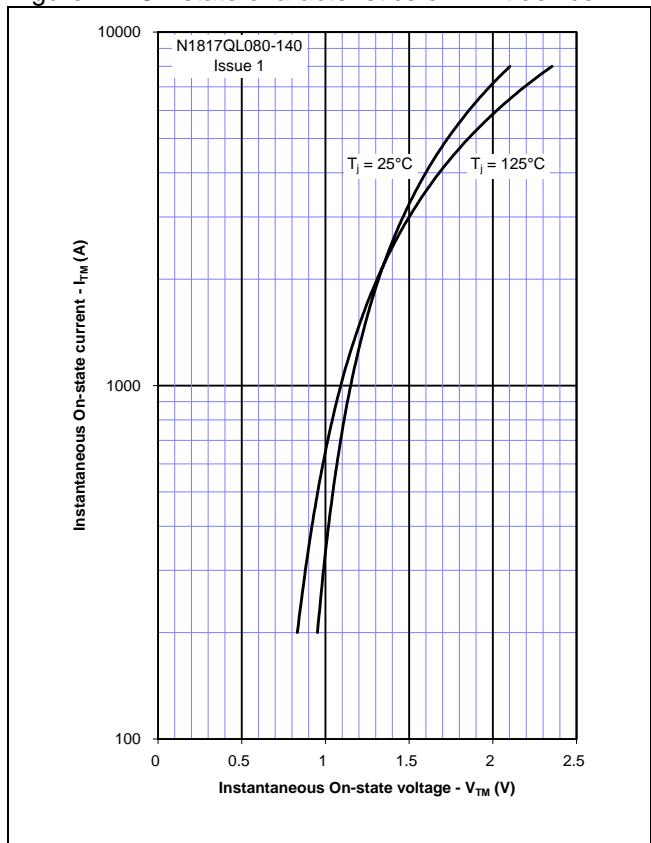
Figure 2 – Transient thermal impedance

N1817QL080-140
Issue 1   SSC 0.046K/W
            DSC 0.023K/W

Thermal impedance (K/W)

Time (s)
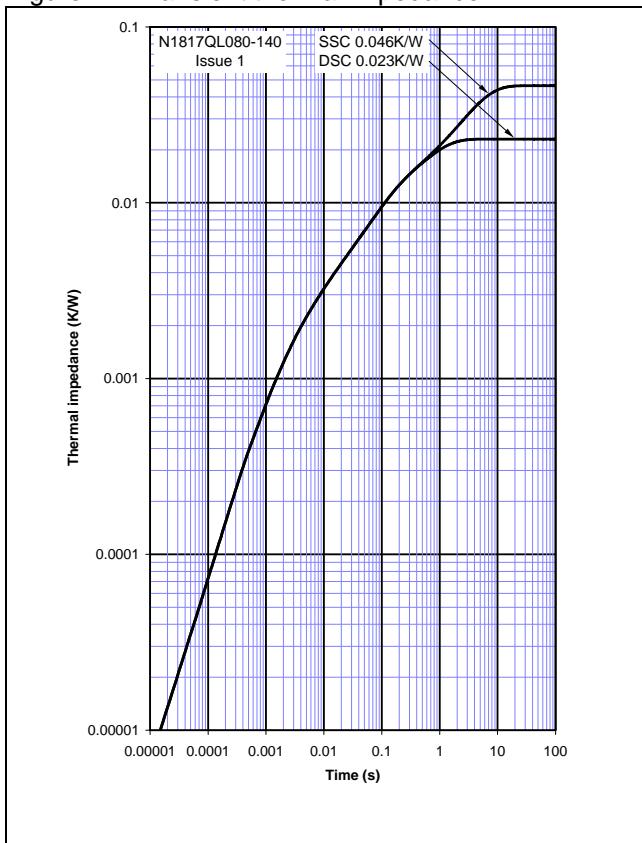
Figure 3 – Gate Characteristics – Trigger limits

N1817QL080-140
Issue 1
$T_j=25°C$

Max V_G dc

I_{GT}, V_{GT}

125°C   25°C   -10°C   -40°C

I_{GD}, V_{GD}

Min V_G dc

Gate Trigger Voltage - V_{GT} (V)

Gate Trigger Current - I_{GT} (A)
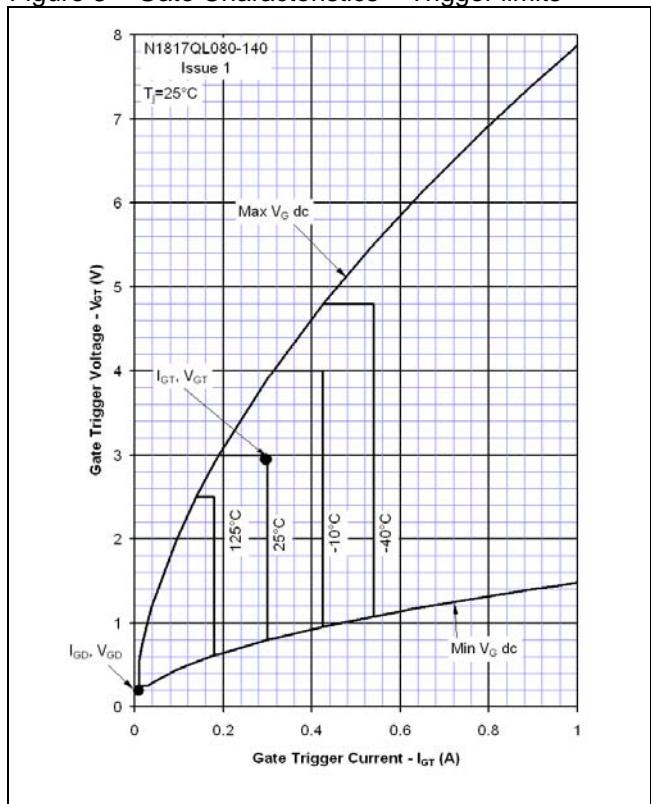
Figure 4 – Gate Characteristics – Power Curves

N1817QL080-140
Issue 1
$T_j=25°C$

Max V_G dc

P_G Max 30W dc

P_G 4W dc

Min V_G dc

Gate Trigger Voltage - V_{GT} (V)

Gate Trigger Current - I_{GT} (A)
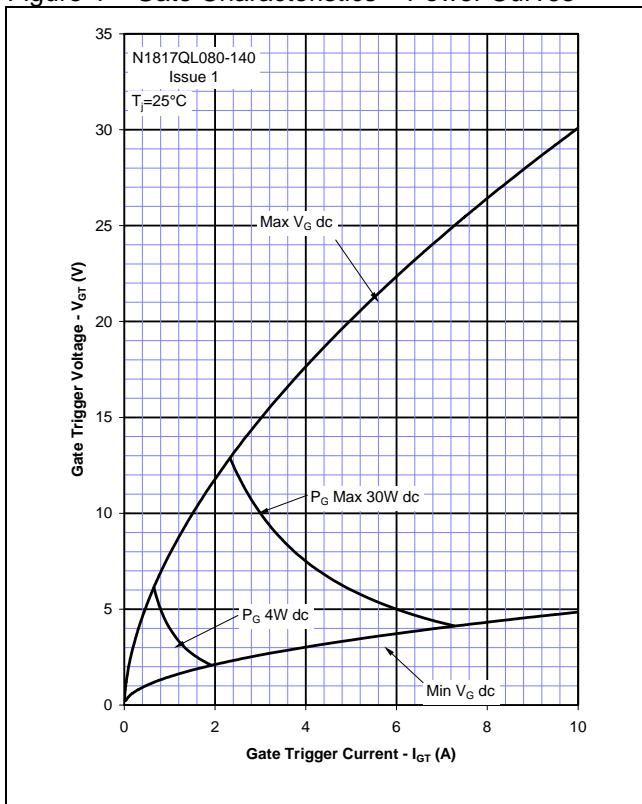
Figure 5 – Total Recovered Charge, Q_{rr}
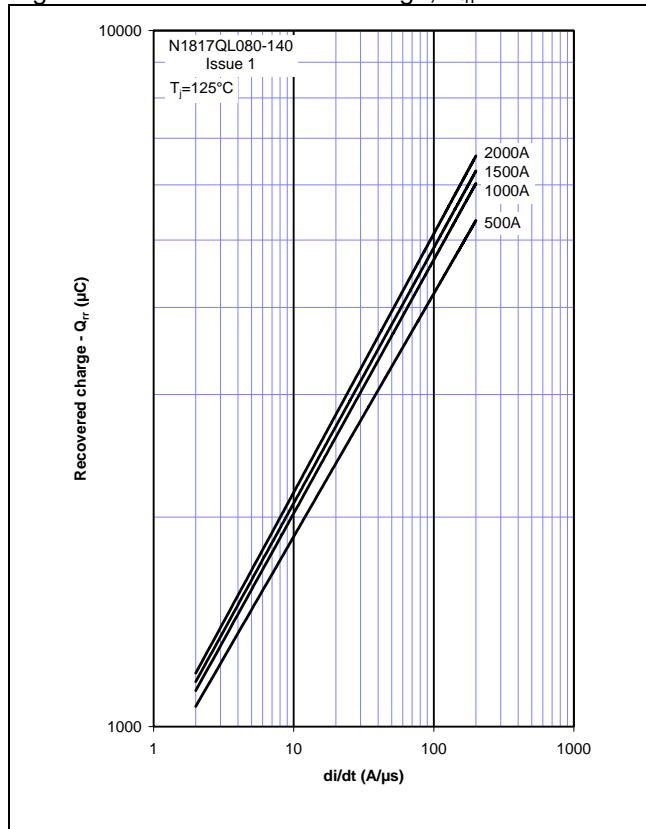
Figure 6 – Recovered Charge, Q_{ra} (50% chord)
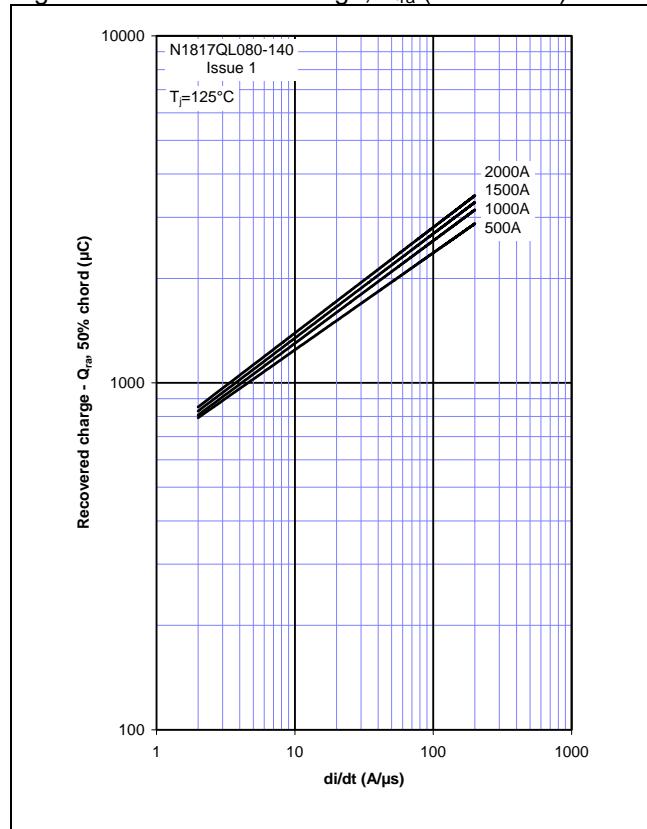
Figure 7 – Peak Reverse Recovery Current, I_{rm}
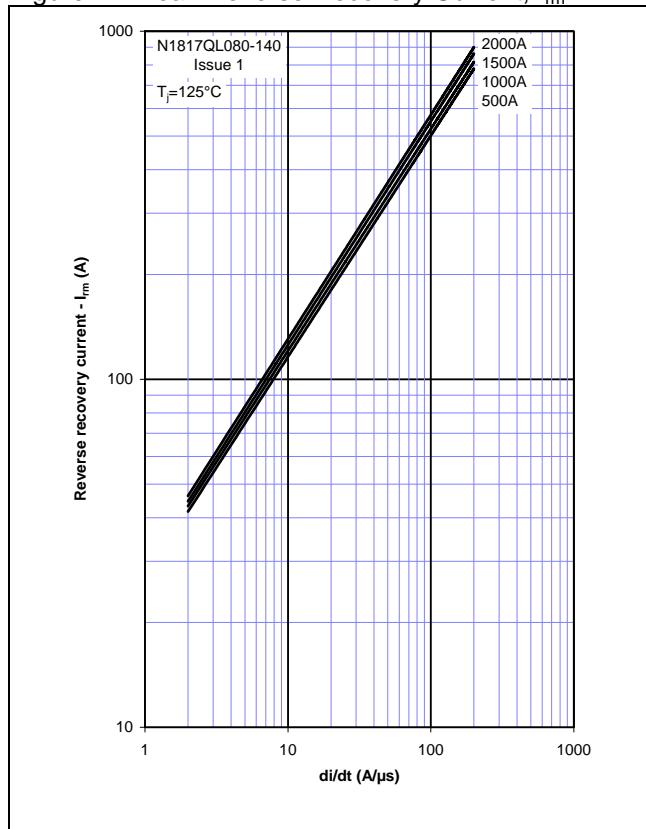
Figure 8 – Maximum Recovery Time, t_{rr} (50% chord)
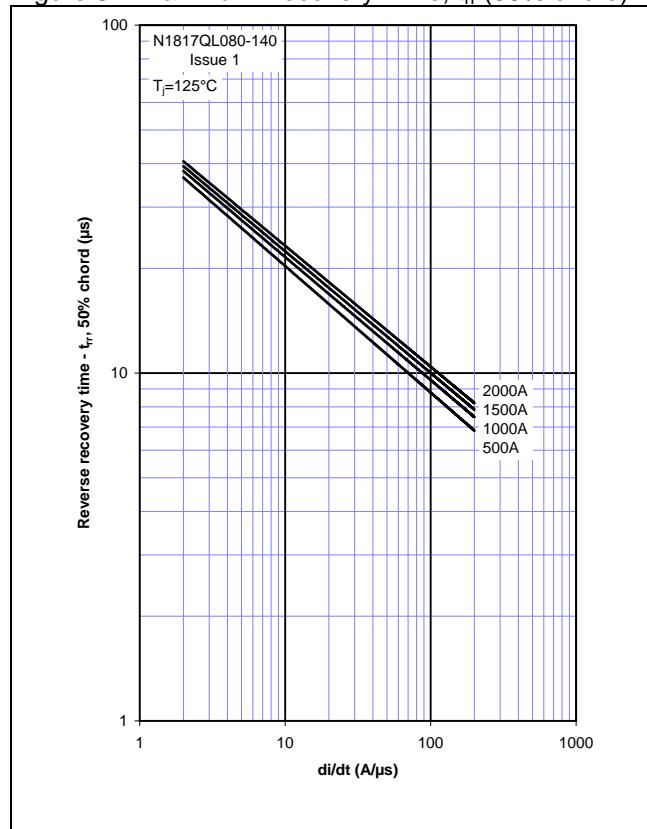
Figure 9 – On-state current vs. Power dissipation –
Double Side Cooled (Sine wave)
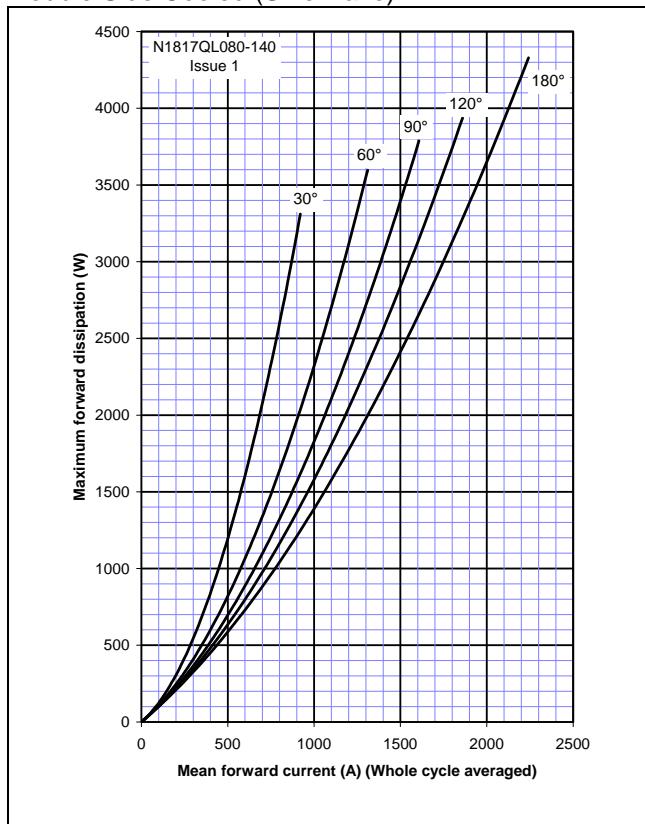
Figure 10 – On-state current vs. Heatsink temperature
– Double Side Cooled (Sine wave)
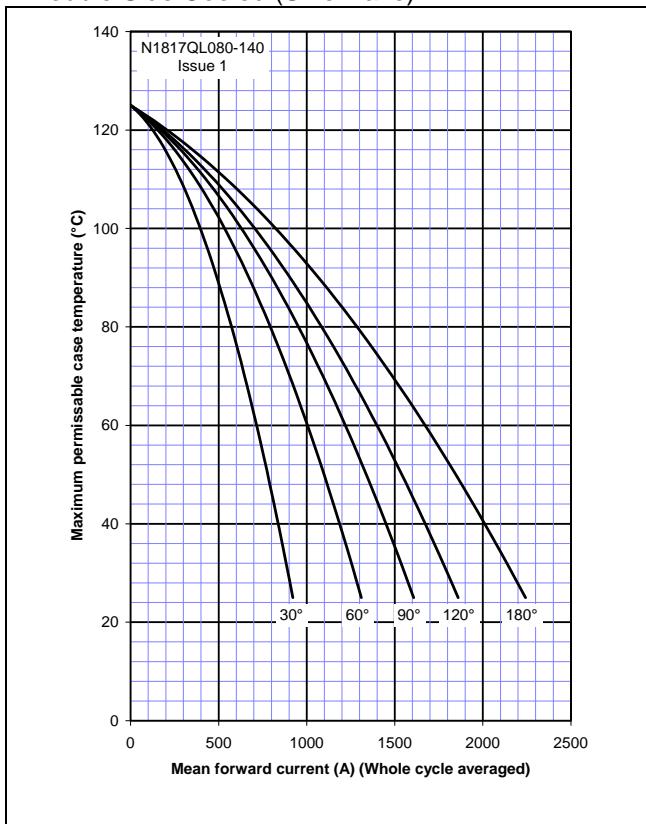
Figure 11 – On-state current vs. Power dissipation –
Double Side Cooled (Square wave)
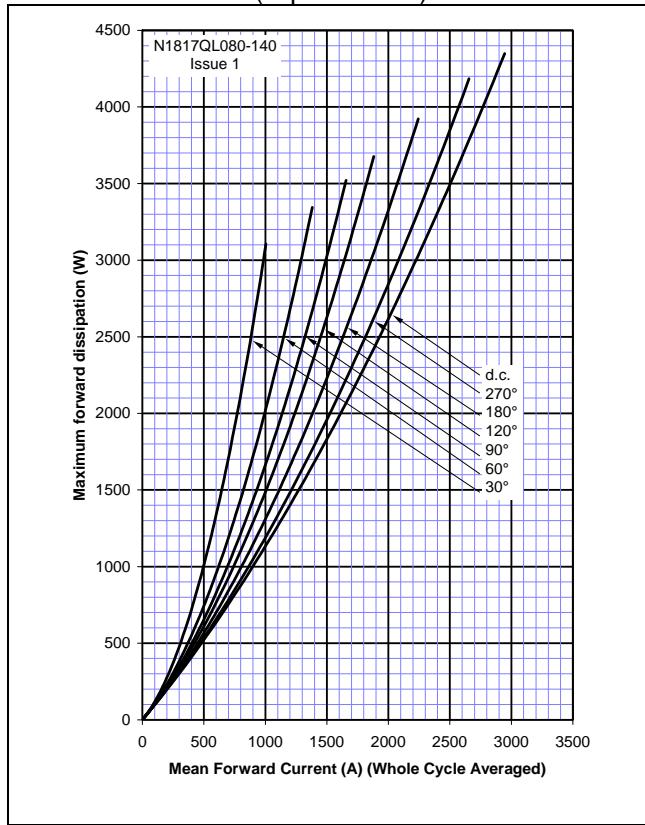
Figure 12 – On-state current vs. Heatsink temperature
– Double Side Cooled (Square wave)
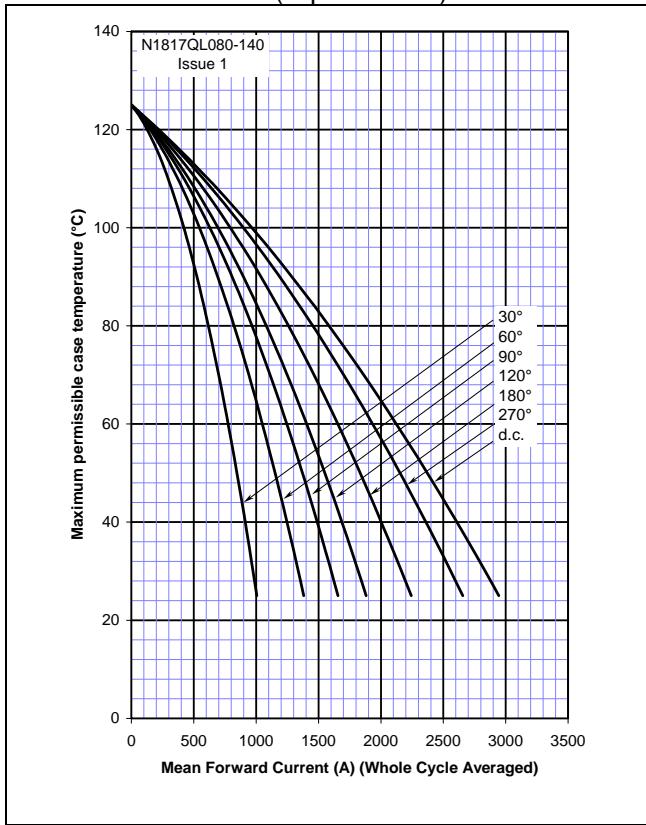
Figure 13 – On-state current vs. Power dissipation –
Single Side Cooled (Sine wave)
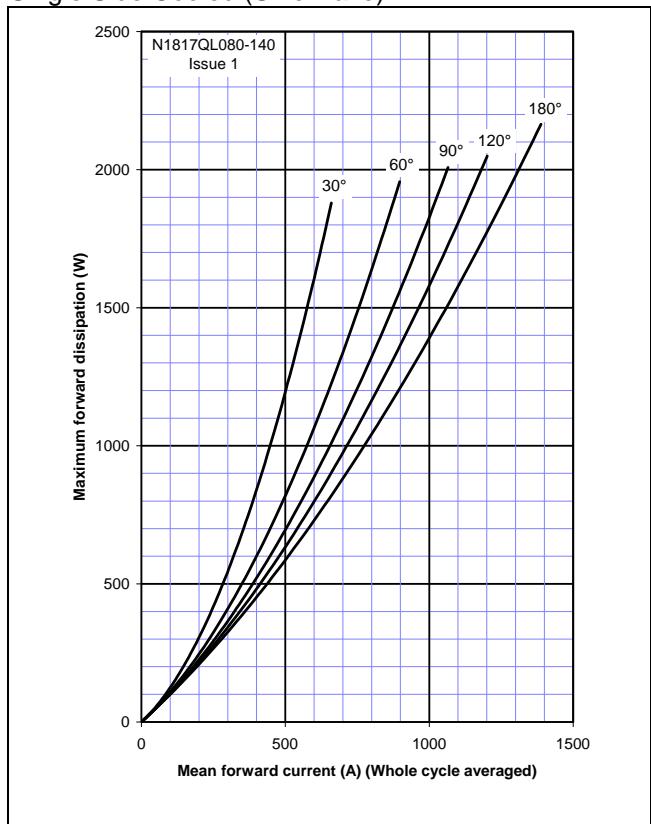
Figure 14 – On-state current vs. Heatsink temperature
– Single Side Cooled (Sine wave)
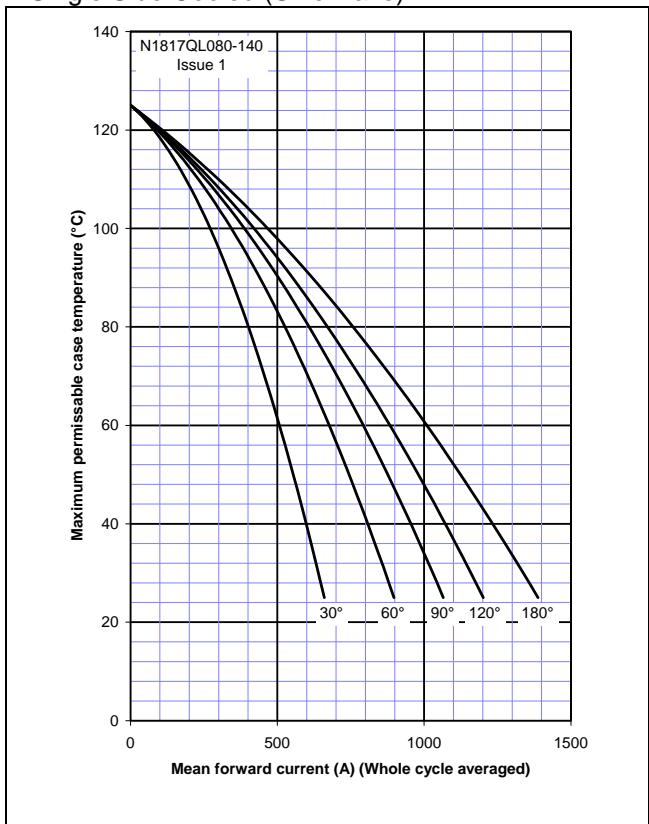
Figure 15 – On-state current vs. Power dissipation –
Single Side Cooled (Square wave)
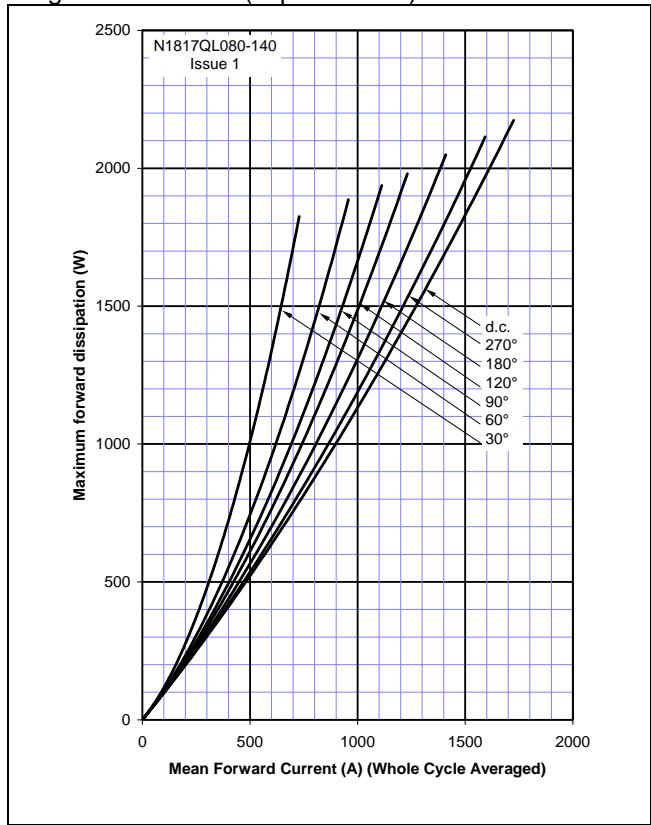
Figure 16 – On-state current vs. Heatsink temperature
– Single Side Cooled (Square wave)
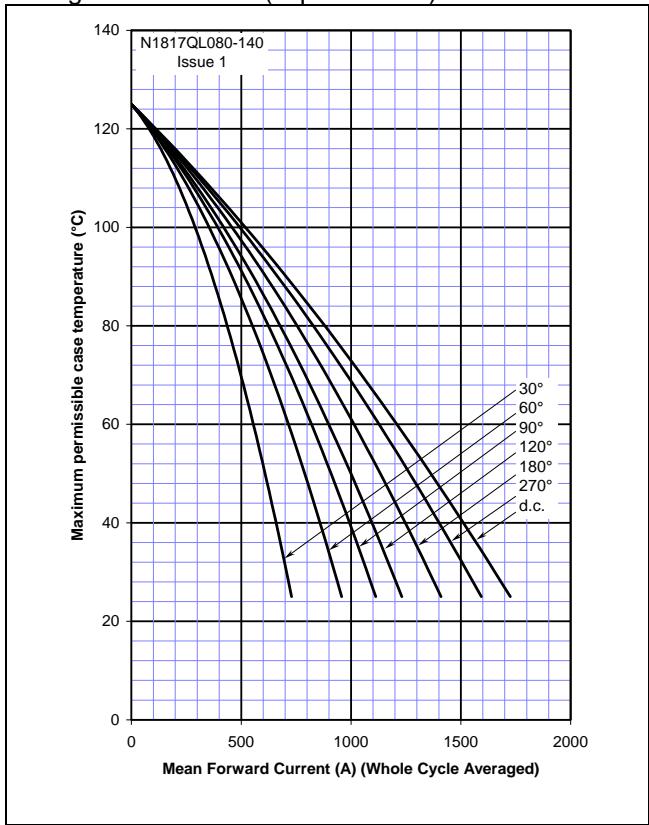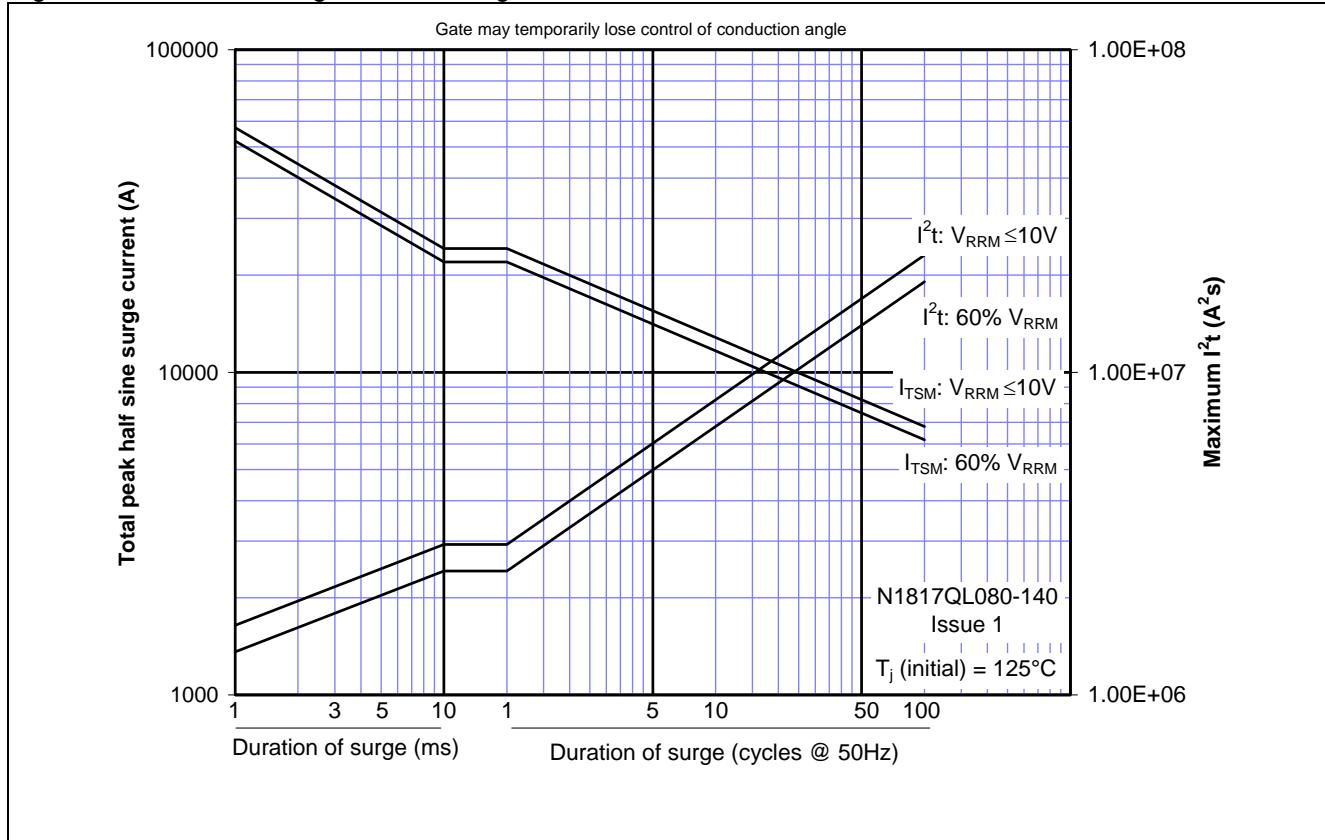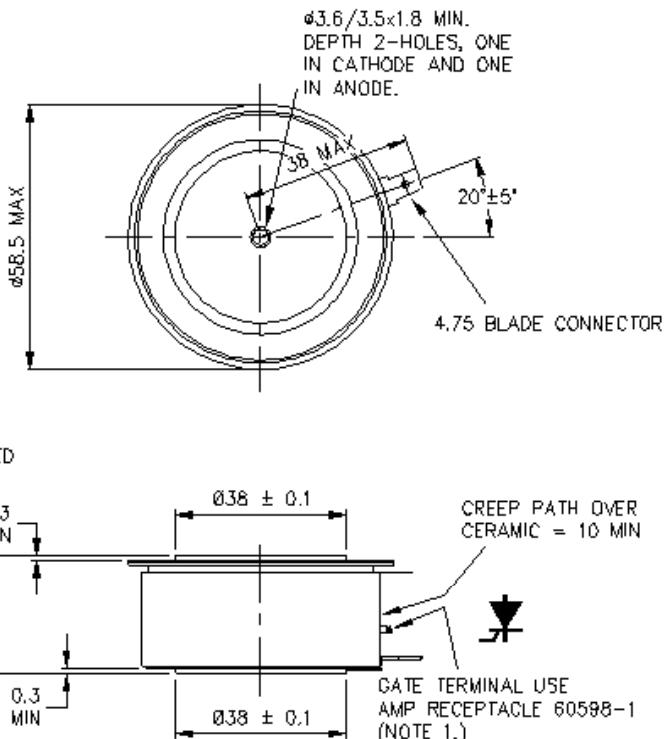
Figure 17 – Maximum surge and I²t Ratings

Outline Drawing & Ordering Information

101A389

ORDERING INFORMATION   (Please quote 10 digit code as below)

N1817	QL	♦♦	0
Fixed Type Code	Fixed outline code	Voltage code $V_{DRM}/100$ 08-14	Fixed turn-off time code

Order code: N1817QL140 – 1400V V_{DRM}, V_{RRM}, 26mm clamp height capsule.